



**MICROCHIP**

## **QUALIFICATION PLAN SUMMARY**

**PCN #: CAAN-21OEIB268**

**Date:  
February 12, 2026**

**Qualification of MMT as a new final test site for SSG2023DW,  
SG2803DW and SG2803DW-TR catalog part numbers (CPN)  
available in 16L and 18L SOIC (.300in) packages.**



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**PACKAGE QUALIFICATION PLAN**

**Purpose:** Qualification of MMT as a new final test site for SSG2023DW, SG2803DW and SG2803DW-TR catalog part numbers (CPN) available in 16L and 18L SOIC (.300in) packages.

**CCB No.:** 8030.009

Test Name	Test Conditions	Sample Size	Qty of Lots	Fail/Accept Criteria
Bin and Yield Comparison	Test the same units at existing and destination locations and compare Bin and Yield data.	33	1	≤0.1%
Parametric / Characterization Comparison	Characterize the same units at existing and destination locations and compare data.	33	1	≤10.0%
Correlation Lot Report	Yield at each step and reject analysis between systems. 33 units are tested as lot correlation.	33	1	≤0.1%